

<b>Notice of References Cited</b>	Application/Control No. 10/648,247	Applicant(s)/Patent Under Reexamination HSU ET AL.	
	Examiner Emmanuel Bayard	Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0038649	02-2004	Lin et al.	455/130
*	B	US-5,668,837	09-1997	Dent, Paul W.	375/316
*	C	US-2001/0014594	08-2001	Khlat et al.	455/303
*	D	US-2004/0121753	06-2004	Sugar et al.	455/333
*	E	US-2004/0069852	04-2004	Seppinen et al.	235/451
*	F	US-6,775,530	08-2004	Severson et al.	455/324
*	G	US-2002/0173337	11-2002	Hajimiri et al.	455/552
*	H	US-6,094,564	07-2000	Tomiya et al.	455/73
*	I	US-7,099,688	08-2006	Wilson, Duane	455/552.1
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.